IGBT - Field Stop, Trench 650 V, 75 A

FGH75T65SHDTL4

Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 3rd generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Features

- Maximum Junction Temperature: T_J =175°C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.6 \text{ V} (Typ.) @ I_C = 75 \text{ A}$
- 100% of the Parts Tested for I_{LM}
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- This Device is Pb-Free and is RoHS Compliant
- Do Not Recommend for Reflow and Full PKG Dipping

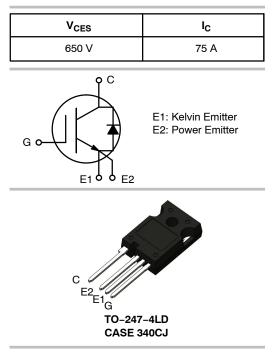
Applications

• Solar Inverter, UPS, Welder, Telecom, ESS, PFC

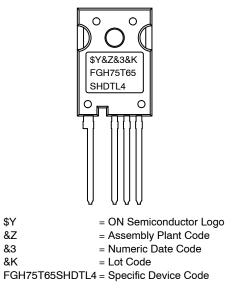


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MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

Symbol	Description		FGH75T65SHDTL4	Unit
V _{CES}	Collector to Emitter Voltage		650	V
V _{GES}	Gate to Emitter Voltage		±20	V
	Transient Gate to Emitter Voltage		±30	V
Ι _C	Collector Current T _C	= 25°C	150	А
	T _C	= 100°C	75	А
I _{LM} (Note 1)	Pulsed Collector Current T _C	= 25°C	300	А
I _{CM} (Note 2)	Pulsed Collector Current		300	А
١ _F	Diode Forward Current T _C	= 25°C	125	А
	Diode Forward Current T _C	= 100°C	75	А
I _{FM} (Note 2)	Pulsed Diode Maximum Forward Current		300	А
PD	Maximum Power Dissipation T _C	= 25°C	455	W
	T _C	= 100°C	227	W
TJ	Operating Junction Temperature		–55 to +175	°C
T _{STG}	Storage Temperature Range		–55 to +175	°C
ΤL	Maximum Lead Temp. for Soldering Purposes, 1/8"	from Case for 5 Seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
V_{CC} = 400 V, V_{GE} = 15 V, I_C = 300 A, R_G = 73 Ω, Inductive Load.
Repetitive rating: Pulse width limited by max. junction temperature.

THERMAL CHARACTERISTICS

Symbol	Parameter	FGH75T65SHDTL4	Unit
R _{θJC} (IGBT)	Thermal Resistance, Junction to Case, Max.	0.33	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	0.65	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FGH75T65SHDTL4	FGH75T65SHDTL4	TO-247-4LD	Tube	-	-	30

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit			
OFF CHARAC	FF CHARACTERISTICS								
BV _{CES}	Collector to Emitter Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	650	-	-	V			
${\Delta{\rm BV}_{\rm CES}/\over \Delta{\rm T_J}}$	Temperature Coefficient of Breakdown Voltage	$I_{C} = 1 \text{ mA}$, Reference to 25°C	-	0.65	_	V/°C			
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	250	μA			
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	I	-	±400	nA			
ON CHARACTERISTICS									
V _{GE(th)}	G-E Threshold Voltage	I_{C} = 75 mA, V_{CE} = V_{GE}	4.0	5.5	7.5	V			

	V _{GE(th)}	G-E Threshold Voltage	$I_C = 75 \text{ mA}, V_{CE} = V_{GE}$	4.0	5.5	7.5	V
ſ	V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 75 A, V _{GE} = 15 V	-	1.6	2.1	V
			I _C = 75 A, V _{GE} = 15 V, T _C = 175°C	-	2.28	-	V

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit		
DYNAMIC CHARACTERISTICS								
C _{ies}	Input Capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	-	3710	-	pF		
C _{oes}	Output Capacitance	= 1 IVITIZ	-	183	-	pF		
C _{res}	Reverse Transfer Capacitance		-	43	-	pF		

T _{d(on)}	Turn-On Delay Time	V _{CC} = 400 V, I _C = 75 A, R _G = 15 Ω, V _{GE} = 15 V,	-	55	-	n
T _r	Rise Time	Inductive Load, $T_C = 25^{\circ}C$	-	50	-	n
T _{d(off)}	Turn-Off Delay Time		-	189	-	n
T _f	Fall Time		-	39	-	n
Eon	Turn-On Switching Loss		-	1.06	-	m
E _{off}	Turn-Off Switching Loss		-	1.56	-	m
E _{ts}	Total Switching Loss		-	2.62	-	m
T _{d(on)}	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, I_C = 75 \text{ A},$	-	48	-	n
Tr	Rise Time	$\frac{1}{10000000000000000000000000000000000$	-	56	-	n
T _{d(off)}	Turn-Off Delay Time		-	205	-	n
T _f	Fall Time		-	40	-	n
Eon	Turn-On Switching Loss		-	2.34	-	m
E _{off}	Turn-Off Switching Loss		-	1.81	-	m
E _{ts}	Total Switching Loss		-	4.15	-	m
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 75 A, V _{GE} = 15 V	-	126	-	n
Q _{ge}	Gate to Emitter Charge	VGE = 13 V	-	24.1	-	n
Q _{gc}	Gate to Collector Charge		-	47.6	-	n(

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS OF THE DIODE (T_C = 25° C unless otherwise noted)

Symbol	Parameter	Test Co	Test Conditions		Тур	Max	Unit
V _{FM}	Diode Forward Voltage	I _F = 75 A	$T_{C} = 25^{\circ}C$	-	1.8	2.1	V
			T _C = 175°C	-	1.7	-	
E _{rec}	Reverse Recovery Energy	I _F = 75 A, dI _F /dt = 200 A/μs	T _C = 175°C	-	160	-	μJ
T _{rr}	Diode Reverse Recovery Time	- αι _F /αι - 200 Α/μο	$T_{\rm C} = 25^{\circ}{\rm C}$	-	76	-	ns
			T _C = 175°C	-	270	-	
Q _{rr}	Diode Reverse Recovery Charge		$T_{C} = 25^{\circ}C$	-	206	-	nC
			$T_{\rm C} = 175^{\circ}{\rm C}$	-	2199	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CHARACTERISTICS

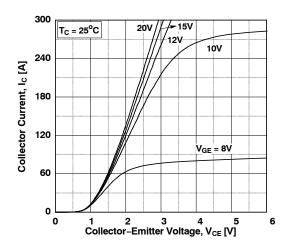


Figure 1. Typical Output Characteristics

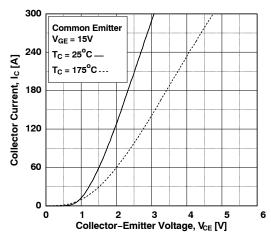


Figure 3. Typical Saturation Voltage Characteristics

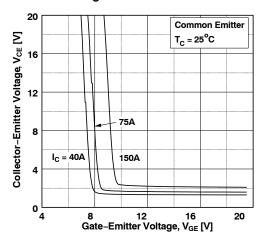


Figure 5. Saturation Voltage vs. V_{GE}

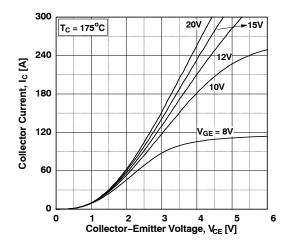


Figure 2. Typical Output Characteristics

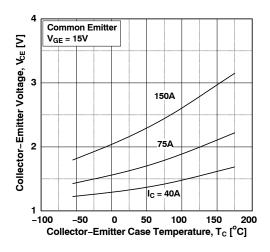


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

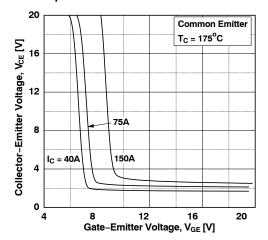


Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

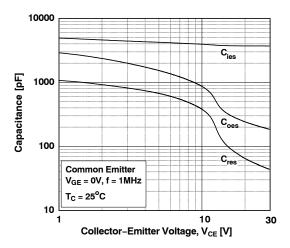
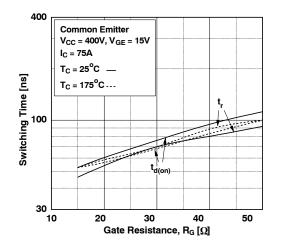


Figure 7. Capacitance Characteristics





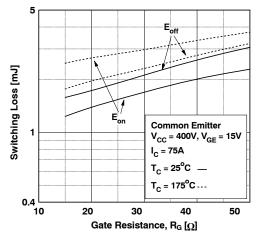


Figure 11. Switching Loss vs. Gate Resistance

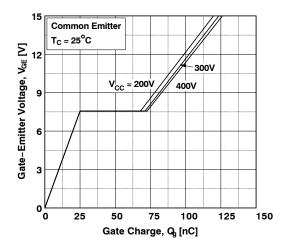


Figure 8. Gate Charge Characteristics

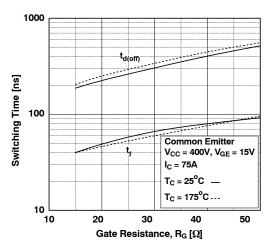


Figure 10. Turn-off Characteristics vs. Gate Resistance

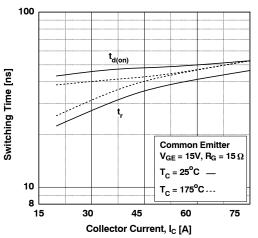
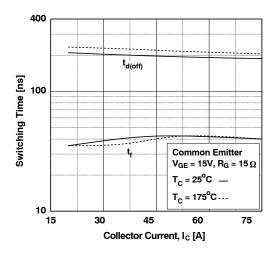


Figure 12. Turn-on Characteristics vs. Collector Current

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)





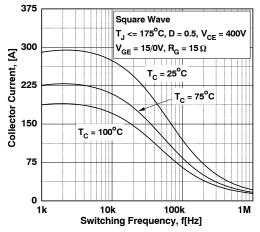


Figure 15. Load Current vs. Frequency

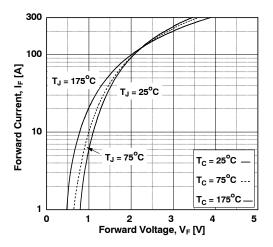


Figure 17. Forward Characteristics

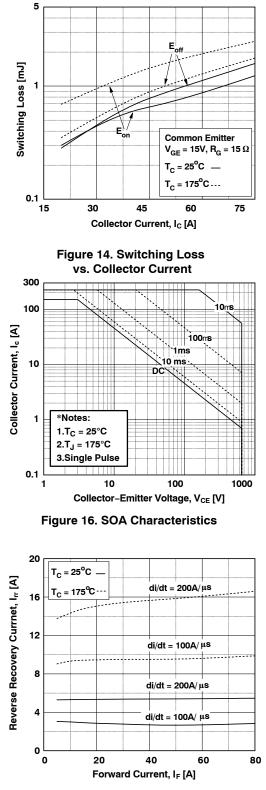


Figure 18. Reverse Recovery Current

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

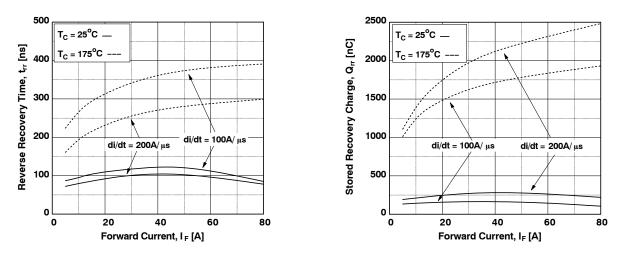


Figure 19. Reverse Recovery Time



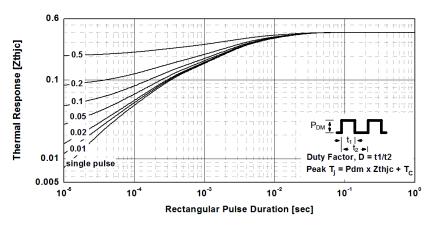


Figure 21. Transient Thermal Impedance of IGBT

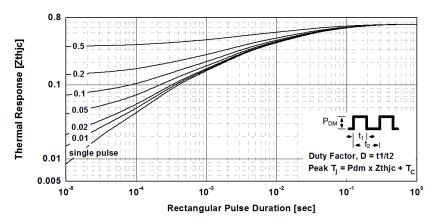
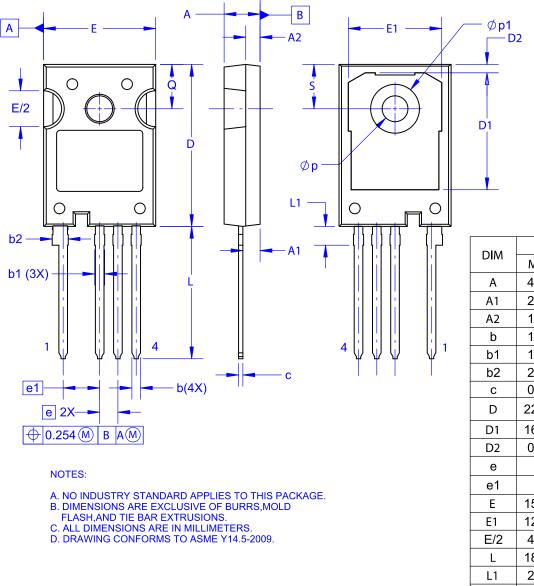


Figure 22. Transient Thermal Impedance of Diode



TO-247-4LD CASE 340CJ ISSUE A

DATE 16 SEP 2019



	MIL	LIMETER	S
DIM	MIN	NOM	MAX
А	4.80	5.00	5.20
A1	2.10	2.40	2.70
A2	1.80	2.00	2.20
b	1.07	1.20	1.33
b1	1.20	1.40	1.60
b2	2.02	2.22	2.42
С	0.50	0.60	0.70
D	22.34	22.54	22.74
D1	16.00	16.25	16.50
D2	0.97	1.17	1.37
е	2	2.54 BSC	2
e1	Ę	5.08 BSC	2
Е	15.40	15.60	15.80
E1	12.80	13.00	13.20
E/2	4.80	5.00	5.20
L	18.22	18.42	18.62
L1	2.42	2.62	2.82
р	3.40	3.60	3.80
p1	6.60	6.80	7.00
Q	5.97	6.17	6.37
S	5.97	6.17	6.37

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